

Notice of References Cited

Application/Control No.

10/542,616

Applicant(s)/Patent Under

Reexamination

AASTRUP ET AL.

Examiner

JOHN FITZGERALD

Art Unit

2856

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,552,274 A	09-1996	Oyama et al.	435/6
*	B US-6,106,149 A	08-2000	Smith, Allan L.	374/31
*	C US-6,189,367 B1	02-2001	Smith et al.	73/19.03
*	D US-6,190,035 B1	02-2001	Smith, Allan L.	374/31
*	E US-6,295,861 B1	10-2001	Tom et al.	73/24.06
*	F US-6,370,939 B2	04-2002	Smith et al.	73/19.03
*	G US-2009/0151428 A1	06-2009	Bhethanabotla et al.	73/24.06
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Josse et al., "Analysis of the Radial Dependence of Mass Sensitivity for Modified-Electrode Quartz Crystal Resonators," Jan. 15, 1998, Analytical Chemistry, Vol. 70, No. 2, ppgs 237-247
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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